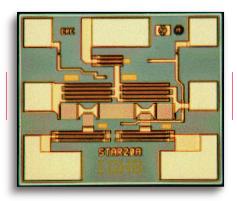
Keysight 1GG7-4082 DC-6 GHz 0/20 dB Single Step Attenuator



Data Sheet

Features

- Frequency range:
 DC to 6.0 GHz
- Attenuation values: Single Bit 20 dB
- Min. insertion loss:< 0.8 @ 3 GHz< 1.4 @ 6 GHz
- Step accuracy: ±0.7 @ 3 GHz ±0.9 @ 6 GHz
- Return loss:20 dB through 3 GHz15 dB through 6 GHz
- P_{-1 dB}:
 25 dBm @ 10 MHz
 30 dBm @ 3 GHz
- DistortionSHI: + 95 dBmTHI: + 65 dBmTOI: + 56 dBm



Description

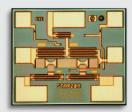
The 1GG7-4082 is a single bit, 0/20 dB single step attenuator designed for low insertion loss and low distortion from DC to 6 GHz. It is intended for use as a general-purpose solid-state step-attenuator for RF instrumentation or commercial communication systems.

This device incorporates two 10 dB "T" attenuators combined with integral series and shunt MESFET switching elements. The 1GG7-4082 also incorporates a unique diode/resistor bias topology to improve low frequency RF performance and is fabricated with Keysight Technologies, Inc. GaAs FET MMIC process which is specifically designed to eliminate GaAs anomalies common in control circuit components.

Absolute maximum ratings¹

Symbol	Parameters/conditions	Min.	Max.	Units
$V_{C1,2}$	Control line voltages	-12	+12	Volts
V _{RF(in/out)}	DC input/output voltage			
P _{in(CW)}	CW RF input power		30	dBm
T _{op}	Operating temperature	-55	+125	°C
T_{st}	Storage temperature	-65	+165	°C
T _{max}	Max. assembly temperature		300	°C

^{1.} Operation in excess of any one of these may result in permanent damage to this device $T_A = 25$ °C except for T_{op} , T_{st} , and T_{max} .



- Chip size: 900 x 760 (35.4 x 29.9 mils)
- Chip size tolerance:
 ±10 μm (±0.4 mils)
- Chip thickness: 127 \pm 15 μ m (5.0 \pm 0.6 mils)
- Small pad dimensions:
 114 x 114 μm (4.5 x 4.5 mils)
- Large pad dimensions:
 114 x 228 μm (4.5 x 9.0 mils)

DC specifications/physical properties

 $(T_A = 25 \, ^{\circ}C)$

Symbol	Parameters/conditions	Min.	Тур.	Max.	Units
V _{C1,2,3,4(+)}	Positive control line voltage	7	10	10.5	Volts
V _{C1,2,3,4(-)}	Negative control line voltage	-10.5	-10	-7	Volts
I _{L(+)}	Positive control line leakage current ($V_{C1,2,3,4} = +10 \text{ volts}$)			50	μΑ
I _{L(-)}	Negative control line leakage current ($V_{C1,2,3,4} = -10$ volts)			50	μΑ

Typical attenuation temperature coefficients

Symbol	Parameters/conditions						Units
	Frequency	50 MHz	1 GHz	2 GHz	3 GHz	4 GHz	
$\alpha_{\!\scriptscriptstyle T}$	@ Min. insertion loss state	.0008	.0008	.0008	.0007	.0006	dBc/°C
	@ -20 dB state	0018	0018	0016	0014	0010	

RF specifications

 $(T_A = 25 \text{ °C}, Z_0 = 50 \Omega, V_{C1,2} = \pm 10 \text{ volts})$

Symbol	Parameters/conditions	Typ. ¹	Min.	Тур.	Max.	Min.	Тур.	Max.	Units
BW	Guaranteed operating bandwidth	0.01		DC to 30			DC to 6.0		GHz
IL _(min)	Minimum insertion loss ($V_{C1} = +10 \text{ v}$, $V_{C2} = -10 \text{ V}$)	0.5		0.7	0.8		1.3	1.4	dB
$\Delta_{ ext{acc.}}$	Attenuation step (@ -20 dB state)		19.3	20	20.3	19.1	19.8	20.4	dB
RL	Return loss				20			15	dB
T_R	Rise time switching speed (10% to 90% of RF swing, $f_0 = 3 \text{ GHz}$)			1			1		μs
SHI	Second harmonic intercept point (Referred to P _{in})			95			65	95	dBm
THI	Third harmonic intercept point (Referred to P _{in})			65			65		dBm
TOI	Two-tone third order lintercept point (For two-tone power levels <+20 dBm) (Referred to $P_{\rm in}$)			56				56	dBm
P _{-1dB}	Input power @ 1 dB increase in insertion loss	25		30			30		dBm
P _{in} (max)	Maximum continuous RF input power				27			27	dBm

^{1.} Typical performance <10 MHz

Applications

The 1GG7-4082 is designed for use in instrumentation, communications, radar, ECM, EW, and many other systems requiring fast switching speed, low distortion to input signals, and high cycle lifetimes. It can be used for pulse modulation, port isolation, replacement of mechanical relays, and in any application requiring the advantages of solid-state performance.

This device does not include any on-chip driver circuitry. An external driver circuit is required to convert TTL or ECL logic signals to the ±10 volt switching levels required by this device.

Figure 3 shows the device assembly diagram for operation through 6 GHz. Dual RF input and output bonds are recommended for assemblies where the device to thin film circuit gap exceeds 10 mils.

Assembly Techniques

This device is compatible with Au-Sn eutectic or conductive epoxy processes. Gold thermosonic ball or wedge bonding is recommended for all bonds. The bond pads are designed to be large enough to facilitate autobonding. The top and bottom metallization is gold.

GaAs MMICs are ESD sensitive. ESD preventive measures must be employed in all aspects of storage, handling, and assembly.

MMIC ESD precautions, handling considerations, die attach and bonding methods are critical factors in successful GaAs MMIC performance and reliability.

Logic table

 $(V_{C1-2}$ typical values in volts)

Attenuation setting	V _{c1}	V _{c2}
Min. insertion loss	+10	-10
-20 dB state	-10	+10

RoHS Compliance

This device is RoHS Compliant. This means the component meets the requirements of the European Parliament and the Council of the European Union Restriction of Hazardous Substances Directive 2011/65/EU, commonly known as RoHS.

The six regulated substances are lead, mercury, cadmium, chromium VI (hexavalent), polybrominated biphenyls (PBB) and polybrominated biphenyl ethers (PBDE). RoHS compliance implies that any residual concentration of these substances is below the RoHS Directive's maximum concentration values (MVC); being less than 1000 ppm by weight for all substances except for cadmium which is less than 100 ppm by weight.

Additional References

Keysight document, *GaAs MMIC ESD*, *Die Attach and Bonding Guidelines - Application Note* (5991-3484EN) provides basic information on these subjects.

Simplified schematic

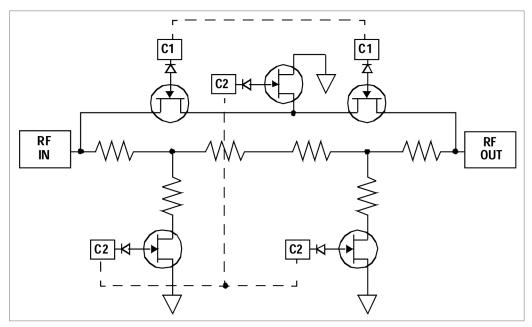


Figure 1. 1GG7-4082 simplified schematic

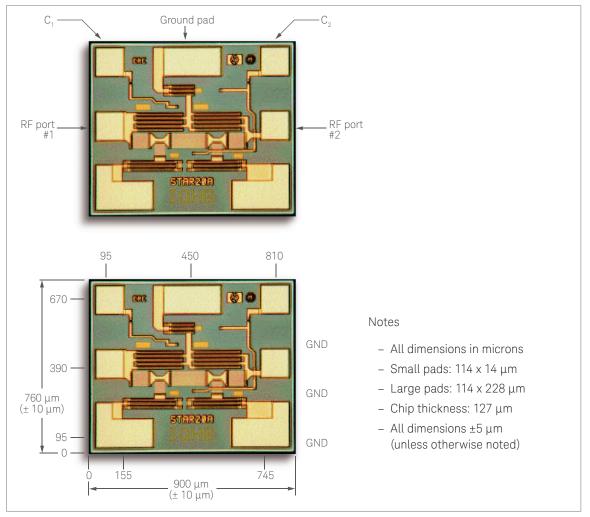


Figure 2. 1GG7-4082 bond pad locations

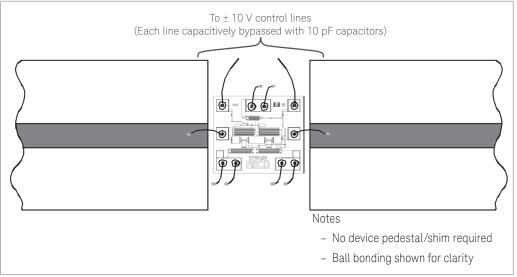


Figure 3. 1GG7-4082 assembly diagram

Supplemental Data

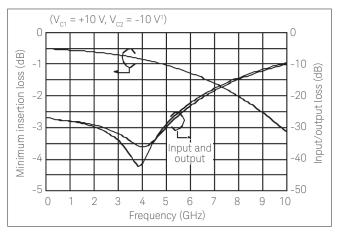


Figure 4. Minimum insertion loss and return loss vs. frequency

1. Data obtained from small-signal linear modeling

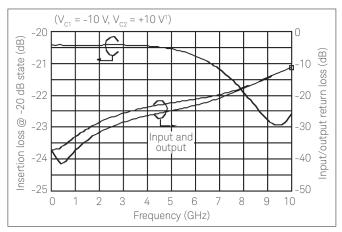


Figure 5. Insertion loss @ -20 dB state and return loss vs. frequency

1. Data obtained from small-signal linear modeling

Typical S-parameters: minimum insertion loss state¹

 $(T_A = +25 \text{ °C}, V_{C1} = +10 \text{ V}, V_{C2} = -10 \text{ V}, Z_{in} = Z_{out} = 50 \Omega)$

Frequency (GHz)		c			c			c			c	
(unz)	dB	S ₁₁ Mag	Ang	dB	S ₁₂ Mag	Ang	dB	S ₂₁ Mag	Ang	dB	S ₂₂ Mag	Ang
0.001	-25.9	0.051	-0.05	-0.45	0.949	-0.01	-0.45	0.949	-0.01	-25.9	0.051	-0.05
0.01	-25.9	0.051	-0.61	-0.45	0.949	-0.13	-0.45	0.949	-0.13	-25.9	0.051	-0.61
0.1	-26.3	0.049	-5.1	-0.48	0.947	-1.2	-0.48	0.947	-1.2	-26.3	0.049	-5.1
0.5	-27.5	0.042	-5.4	-0.54	0.940	-5.1	-0.54	0.940	-5.1	-27.6	0.042	-5.2
1.0	-27.9	0.040	-5.2	-0.56	0.938	-10.0	-0.56	0.938	-10.0	-28.1	0.040	-4.8
1.5	-28.4	0.038	-6.9	-0.58	0.935	-14.9	-0.58	0.935	-14.9	-28.7	0.037	-6.1
2.0	-29.1	0.035	-10.2	-0.61	0.932	-19.8	-0.61	0.932	-19.8	-29.7	0.033	-8.6
2.5	-30.2	0.031	-15.7	-0.65	0.927	-24.8	-0.65	0.927	-24.8	-31.4	0.027	-12.8
3.0	-31.8	0.026	-25.0	-0.71	0.922	-29.8	-0.71	0.922	-29.8	-34.0	0.020	-20.7
3.5	-34.1	0.020	-42.5	-0.77	0.916	-34.8	-0.77	0.916	-34.8	-38.7	0.012	-41.5
4.0	-36.1	0.016	-78.1	-0.84	0.908	-39.8	-0.84	0.908	-39.8	-41.6	0.008	-115.2
4.5	-34.1	0.020	-122.9	-0.92	0.899	-44.9	-0.92	0.899	-44.9	-34.3	0.019	-161.7
5.0	-29.9	0.032	-149.5	-1.0	0.889	-50.0	-1.0	0.889	-50.0	-29.0	0.035	-175.8
5.5	-26.2	0.049	-163.9	-1.1	0.877	-55.1	-1.1	0.877	-55.1	-25.2	0.055	176.5
6.0	-23.2	0.069	-173.5	-1.3	0.864	-60.2	-1.3	0.864	-60.2	-22.3	0.077	170.6
7.0	-18.5	0.119	172.7	-1.6	0.832	-70.5	-1.6	0.832	-70.5	-17.7	0.130	160.7
8.0	-15.0	0.179	161.3	-2.0	0.794	-80.8	-2.0	0.794	-80.8	-14.4	0.191	151.3
9.0	-12.2	0.245	150.8	-2.5	0.749	-91.0	-2.5	0.749	-91.0	-11.7	0.259	142.2
10.0	-10.0	0.315	140.9	-3.1	0.698	-100.9	-3.1	0.698	-100.9	-9.6	0.330	133.2

Typical S-parameters: @ -20 dB state¹

(T_A = +25 °C, V_{C1} = -10 V, V_{C2} = +10 V, Z_{in} = Z_{out} = 50 Ω)

Frequency (GHz)		c.		out 00 11/	S ₁₂			S ₂₁			c	
(unz)	dB	S ₁₁ Mag	Ang	dB	Mag	Ang	dB	Mag	Ang	dB	S₂₂ Mag	Ang
0.001	-37.2	0.014	-0.05	-20.4	0.096	-0.008	-20.4	0.096	-0.008	-37.0	0.014	0.10
0.01	-37.2	0.014	-0.75	-20.4	0.096	-0.08	-20.4	0.096	-0.08	-37.0	0.014	0.71
0.1	-37.9	0.013	-6.3	-20.4	0.096	-0.76	-20.4	0.096	-0.76	-37.0	0.014	6.4
0.5	-41.2	0.008	28.2	-20.4	0.095	-3.1	-20.4	0.095	-3.1	-35.8	0.016	32.6
1.0	-37.2	0.014	60.8	-20.4	0.095	-6.1	-20.4	0.095	-6.1	-33.0	0.022	51.9
1.5	-33.9	0.020	71.8	-20.4	0.095	-9.1	-20.4	0.095	-9.1	-30.5	0.030	61.8
2.0	-31.6	0.026	77.3	-20.4	0.095	-12.3	-20.4	0.095	-12.3	-28.5	0.037	67.5
2.5	-29.9	0.032	81.1	-20.4	0.095	-15.6	-20.4	0.095	-15.6	-26.9	0.045	71.3
3.0	-28.5	0.038	84.2	-20.4	0.095	-19.2	-20.4	0.095	-19.2	-25.7	0.052	74.1
3.5	-27.3	0.043	87.3	-20.4	0.095	-22.9	-20.4	0.095	-22.9	-24.6	0.059	76.5
4.0	-26.4	0.048	90.6	-20.5	0.095	-27.0	-20.5	0.095	-27.0	-23.7	0.065	78.8
4.5	-25.6	0.053	94.4	-20.5	0.095	-31.5	-20.5	0.095	-31.5	-23.0	0.071	81.3
5.0	-24.8	0.057	98.8	-20.5	0.094	-36.4	-20.5	0.094	-36.4	-22.4	0.076	84.2
5.5	-24.0	0.063	103.9	-20.6	0.093	-41.9	-20.6	0.093	-41.9	-21.8	0.081	87.8
6.0	-23.2	0.069	109.7	-20.8	0.092	-48.1	-20.8	0.092	-48.1	-21.2	0.087	92.0
7.0	-20.9	0.090	121.8	-21.2	0.087	-63.7	-21.2	0.087	-63.7	-19.8	0.102	102.8
8.0	-17.9	0.127	130.9	-21.9	0.080	-85.8	-21.9	0.080	-85.8	-17.6	0.131	114.2
9.0	-14.5	0.188	133.7	-22.8	0.073	-119.5	-22.8	0.073	-119.5	-14.6	0.186	121.0
10.0	-11.3	0.271	129.6	-22.6	0.074	-168.5	-22.6	0.074	-168.5	-11.4	0.268	120.3

1. Data obtained from small-signal linear modeling

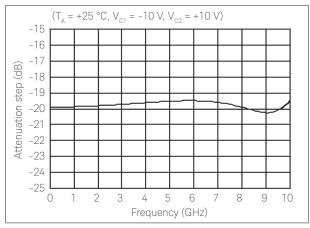


Figure 6. Attenuation step values vs. frequency

Typical attenuation step values¹

 $(T_A = +25 \text{ °C}, V_{C1} = -10 \text{ v}, V_{C2} = +10 \text{ v}, Z_{in} = Z_{out} = 50 \Omega)$

, , ,	, 02 , 111						
Frequency (GHz)	-20 dB state (dB)						
0.001	-19.9						
0.01	-19.9						
0.1	-19.9						
0.5	-19.9						
1.0	-19.9						
1.5	-19.8						
2.0	-19.8						
2.5	-19.8						
3.0	-19.7						
3.5	-19.7						
4.0	-19.6						
4.5	-19.6						
5.0	-19.5						
5.5	-19.5						
6.0	-19.5						
6.5	-19.5						
7.0	-19.6						
7.5	-19.7						
8.0	-19.9						
8.5	-20.1						
9.0	-20.2						
9.5	-20.1						
10.0	-19.4						

Data obtained from small-signal linear modeling

Evolving

Our unique combination of hardware, software, support, and people can help you reach your next breakthrough. We are unlocking the future of technology.







From Hewlett-Packard to Agilent to Keysight

myKeysight

myKeysight

www.keysight.com/find/mykeysight

A personalized view into the information most relevant to you.

KEYSIGHT SERVICES
Accelerate Technology Adoption.
Lower costs.

Keysight Services

www.keysight.com/find/service

Keysight Services can help from acquisition to renewal across your instrument's lifecycle. Our comprehensive service offerings—one-stop calibration, repair, asset management, technology refresh, consulting, training and more—helps you improve product quality and lower costs.

Keysight Channel Partners

www.keysight.com/find/channelpartners

Get the best of both worlds: Keysight's measurement expertise and product breadth, combined with channel partner convenience.

This data sheet contains a variety of typical and guaranteed performance data. The information supplied should not be interpreted as a complete list of circuit specifications. Customers considering the use of this, or other Keysight Technologies GaAs ICs, for their design should obtain the current production specifications from Keysight. In this data sheet the term typical refers to the 50th percentile performance. For additional information contact Keysight at MMIC_Helpline@keysight.com.

The product described in this data sheet is RoHS Compliant. See RoHS Compliance section for more details.

www.keysight.com/find/mmic

For more information on Keysight Technologies' products, applications or services, please contact your local Keysight office. The complete list is available at: www.keysight.com/find/contactus

Americas

Canada (877) 894 4414 Brazil 55 11 3351 7010 Mexico 001 800 254 2440 United States (800) 829 4444

Asia Pacific

1 800 629 485 Australia 800 810 0189 China Hong Kong 800 938 693 India 1 800 11 2626 Japan 0120 (421) 345 080 769 0800 Korea Malaysia 1 800 888 848 Singapore 1 800 375 8100 Taiwan 0800 047 866 Other AP Countries (65) 6375 8100

Europe & Middle East

For other unlisted countries:

www.keysight.com/find/contactus (BP-06-08-16)

Opt. 3 (IT)

0800 0260637



United Kingdom

www.keysight.com/go/quality Keysight Technologies, Inc. DEKRA Certified ISO 9001:2015 Quality Management System

KEYSIGHT TECHNOLOGIES Unlocking Measurement Insights This information is subject to change without notice. © Keysight Technologies, 2016
Published in USA, September 28, 2016
5992-1815EN
www.keysight.com